

# IRFY9140C, IRFY9140CM

# Power MOSFET Thru-Hole (TO-257AA) -100V, P-channel, HEXFET™ MOSFET Technology

### Features

- Simple drive requirements
- Hermetically sealed
- Electrically Isolated
- Ceramic eyelets
- Ideal suited for space level applications
- ESD Rating: Class 2 per MIL-STD-750, Method 1020

# **Potential Applications**

- DC-DC converter
- Motor drives

# **Product Validation**

Adhered to JANTX screening flow according to MIL-PRF-19500 for high-reliability applications

# Description

HEXFET MOSFET technology is the key to IR Hirel advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

# **Ordering Information**

**Ordering options** 

Table 1

Part number	Package	Screening Level				
IRFY9140C	TO-257AA	COTS				
IRFY9140CM	TO-257AA	COTS				
IRFY9140CSCX	TO-257AA	JANTX-equivalent				

# **Product Summary**

- **BV**<sub>DSS</sub>: -100V
- I<sub>D</sub>:-15.8A
- **R**<sub>DS(on),max</sub>: 0.20Ω
- **Q**<sub>G, max</sub>: 60nC



PD-91294F



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**Absolute Maximum Ratings** 

# 1 Absolute Maximum Ratings

Table 2   Absolute Maximum Rating						
Symbol	Parameter	Value	Unit			
$I_{D1} @ V_{GS} = -10V, T_C = 25^{\circ}C$	Continuous Drain Current	-15.8	А			
$I_{D2} @ V_{GS} = -10V, T_C = 100^{\circ}C$	Continuous Drain Current	-10	А			
I <sub>DM</sub> @ T <sub>c</sub> = 25°С	Pulsed Drain Current <sup>1</sup>	-60	А			
$P_{D} @ T_{C} = 25^{\circ}C$	Maximum Power Dissipation	100	W			
	Linear Derating Factor	0.8	W/°C			
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V			
E <sub>AS</sub>	Single Pulse Avalanche Energy <sup>2</sup>	640	mJ			
I <sub>AR</sub>	Avalanche Current <sup>1</sup>	-15.8	А			
E <sub>AR</sub>	Repetitive Avalanche Energy <sup>1</sup>	10	mJ			
dv/dt	Peak Diode Reverse Recovery <sup>3</sup>	-5.5	V/ns			
T₋ T <sub>stg</sub>	Operating Junction and Storage Temperature Range	-55 to +150	°C			
	Lead Temperature	300 (0.063in./1.6mm from case for 10s)				
	Weight	4.3 (Typical)	g			

<sup>&</sup>lt;sup>1</sup> Repetitive Rating: Pulse width limited by maximum junction temperature.

 $<sup>^2</sup>$  V\_{DD} = -50V, starting T\_J = 25°C, L = 5.1mH, Peak I\_L = -15.8A, V\_{GS} = -10V

 $<sup>^3</sup>$  I\_{SD}  $\leq$  -15.8A,  $di/dt \leq$  -200A/µs, V\_{DD}  $\leq$  -100V,  $T_{\rm J} \leq$  150°C



**Device Characteristics** 

# 2 Device Characteristics

### 2.1 Electrical Characteristics

### Table 3 Static and Dynamic Electrical Characteristics @ T<sub>j</sub> = 25°C (Unless Otherwise Specified)

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions		
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	-100	_	_	V	$V_{GS} = 0V, I_{D} = -1.0mA$		
$\Delta \text{BV}_{\text{DSS}} / \Delta \text{T}_{\text{J}}$	Breakdown Voltage Temp. Coefficient	_	-0.1	_	V/°C	Reference to 25°C, I <sub>D</sub> = -1.0mA		
R <sub>DS(on)</sub>	Static Drain-to-Source On-State Resistance	_	_	0.20	Ω	$V_{GS} = -10V$ , $I_{D2} = -10A^{1}$		
V <sub>GS(th)</sub>	Gate Threshold Voltage	-2.0	_	-4.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$		
Gfs	Forward Transconductance	6.2	_	-	S	$V_{DS}$ = -15V, $I_{D2}$ = -10A <sup>1</sup>		
1	Zara Cata Valtaga Drain Current	_	_	-25		$V_{DS} = -80V, V_{GS} = 0V$		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	_	_	-250	μA	$V_{DS} = -80V, V_{GS} = 0V, T_{J} = 125^{\circ}C$		
	Gate-to-Source Leakage Forward	d — — -100		$V_{GS} = -20V$				
I <sub>GSS</sub>	Gate-to-Source Leakage Reverse	_	_	100	nA	$V_{GS} = 20V$		
Q <sub>G</sub>	Total Gate Charge	_	_	60		I <sub>D1</sub> = -15.8A		
Q <sub>GS</sub>	Gate-to-Source Charge	_	_	13	nC	$V_{DS} = -50V$		
$Q_{GD}$	Gate-to-Drain ('Miller') Charge	_	_	35.2		$V_{GS} = -10V$		
t <sub>d(on)</sub>	Turn-On Delay Time	_	_	35		I <sub>D1</sub> = -15.8A **		
t <sub>r</sub>	Rise Time	_	_	85		$V_{DD} = -50V$		
t <sub>d(off)</sub>	Turn-Off Delay Time	_	—	85	ns	$R_{G} = 7.5\Omega$		
t <sub>f</sub>	Fall Time	_	_	65		$V_{GS} = -10V$		
L <sub>s</sub> +L <sub>D</sub>	Total Inductance	_	6.8	_	nH	Measured from Drain lead (6mm /0.25in. from package) to Source lead (6mm /0.25in. From package) with Source wires internally bonded from Source Pin to Drain Pad		
C <sub>iss</sub>	Input Capacitance	_	1400	_		$V_{GS} = 0V$		
C <sub>oss</sub>	Output Capacitance	_	600	_	рF	$V_{DS} = -25V$		
C <sub>rss</sub>	Reverse Transfer Capacitance	_	200	_	<i>f</i> = 1.0MHz			

\*\* Switching speed maximum limits are based on manufacturing test equipment and capability.

 $<sup>^1</sup>$  Pulse width  $\leq$  300  $\mu s$ ; Duty Cycle  $\leq$  2%



**Device Characteristics** 

# 2.2 Source-Drain Diode Ratings and Characteristics

#### Table 4 Source-Drain Diode Characteristics

Symbol	Parameter		Min. Typ. Ma		Unit	Test Conditions	
ls	Continuous Source Current (Body Diode)		_	-15.8	А		
I <sub>SM</sub>	Pulsed Source Current (Body Diode) <sup>1</sup>	_	_	-60	А		
V <sub>SD</sub>	Diode Forward Voltage	_	_	-5.0	V	$T_J = 25^{\circ}C$ , $I_S = -15.8A$ , $V_{GS} = 0V^{-2}$	
t <sub>rr</sub>	Reverse Recovery Time	_	_	280	ns	$T_{J} = 25^{\circ}C, I_{F} = -15.8A, V_{DD} \le -50V$	
Q <sub>rr</sub>	Reverse Recovery Charge	_	2.4	_	μC	$di/dt = -100A/\mu s^{2}$	
t <sub>on</sub>	Forward Turn-On Time		sic turn-	on time i	is negligi	ble (turn-on is dominated by $L_s+L_D$ )	

# 2.3 Thermal Characteristics

### Table 5 Thermal Resistance

Symbol	Parameter	Min.	Тур.	Max.	Unit
R <sub>θJC</sub>	Junction-to-Case	_	_	1.25	
$R_{\theta JCS}$	Case-to-Sink	_	0.21	_	°C/W
$R_{\theta JA}$	Junction-to-Ambient (Typical socket mount)	_	_	80	

<sup>&</sup>lt;sup>1</sup> Repetitive Rating; Pulse width limited by maximum junction temperature.

 $<sup>^2</sup>$  Pulse width  $\leq$  300  $\mu s;$  Duty Cycle  $\leq$  2%

# IRFY9140C, IRFY9140CM **Power MOSFET THRU-HOLE (TO-257AA)**



**Electrical Characteristics Curves** 

# **Electrical Characteristics Curves**

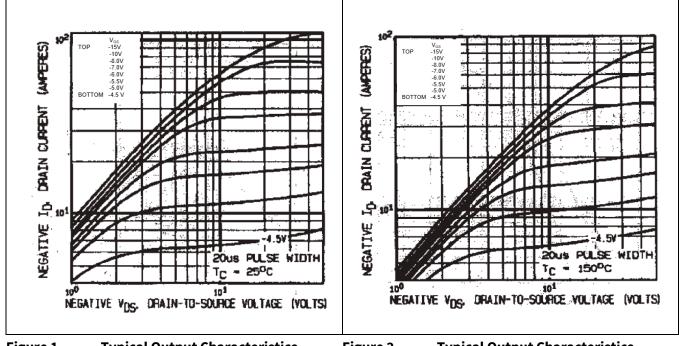


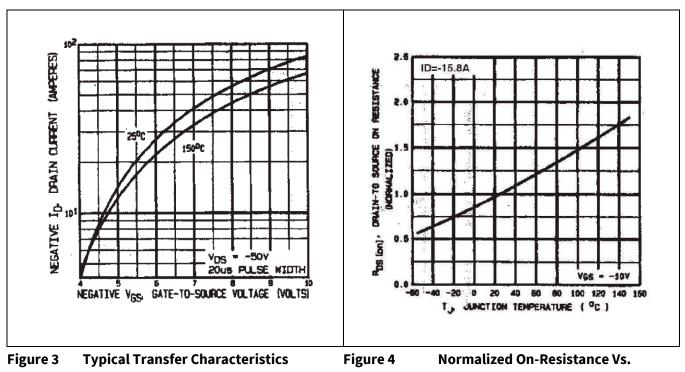
Figure 1

3

**Typical Output Characteristics** 

Figure 2

**Typical Output Characteristics** 

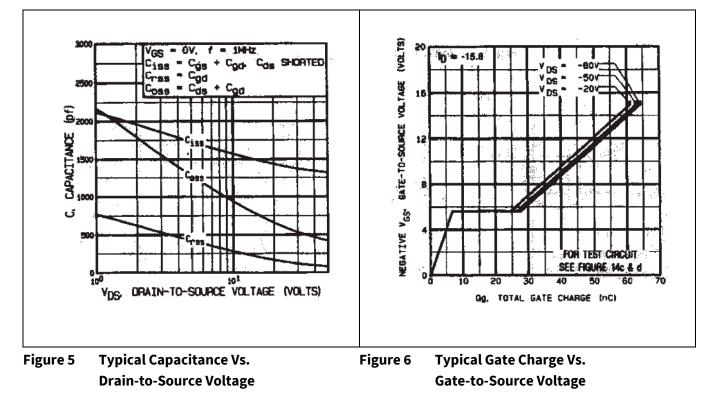


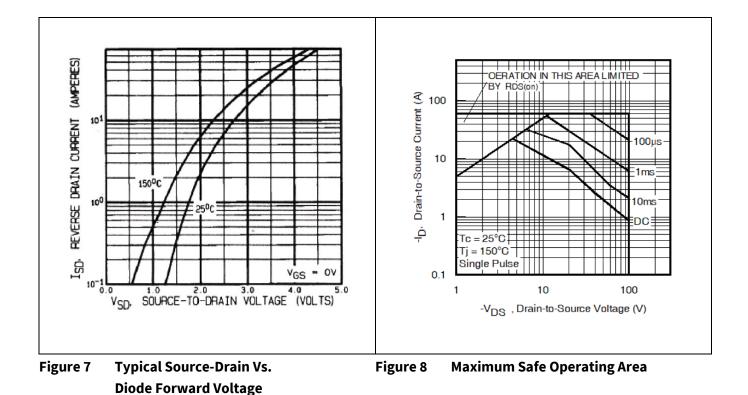
Temperature

# IRFY9140C, IRFY9140CM Power MOSFET THRU-HOLE (TO-257AA)



### **Electrical Characteristics Curves**



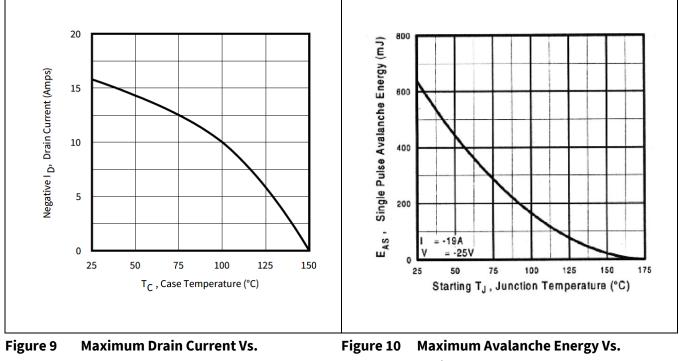


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# **IRFY9140C, IRFY9140CM** Power MOSFET THRU-HOLE (TO-257AA)



### **Electrical Characteristics Curves**



Case Temperature

ire 10 Maximum Avalanche Energy Vs. Drain Current

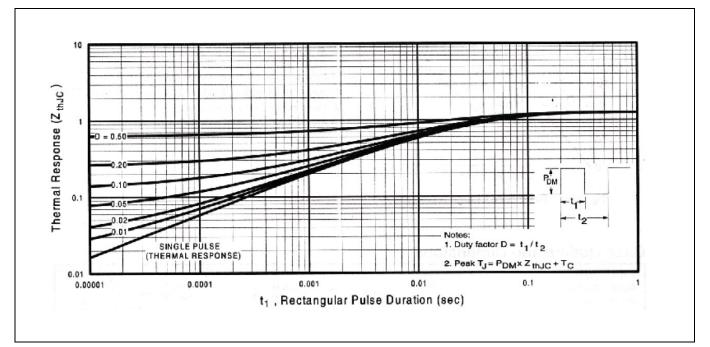
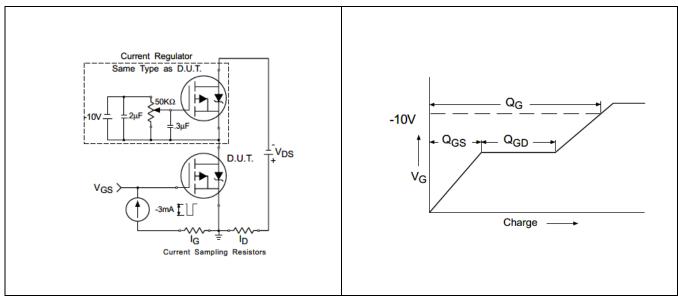


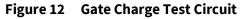
Figure 11 Maximum Effective Transient Thermal Impedance, Junction-to-Case

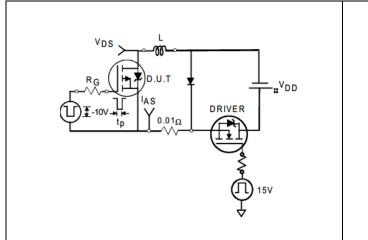


**Test Circuits (Pre-irradiation)** 

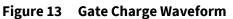
# 4 Test Circuits (Pre-irradiation)

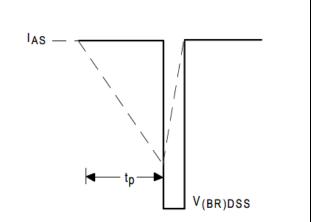




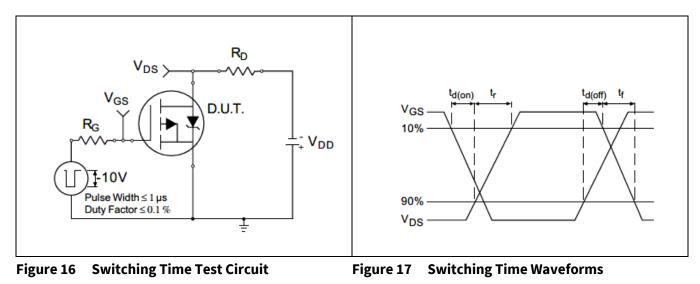










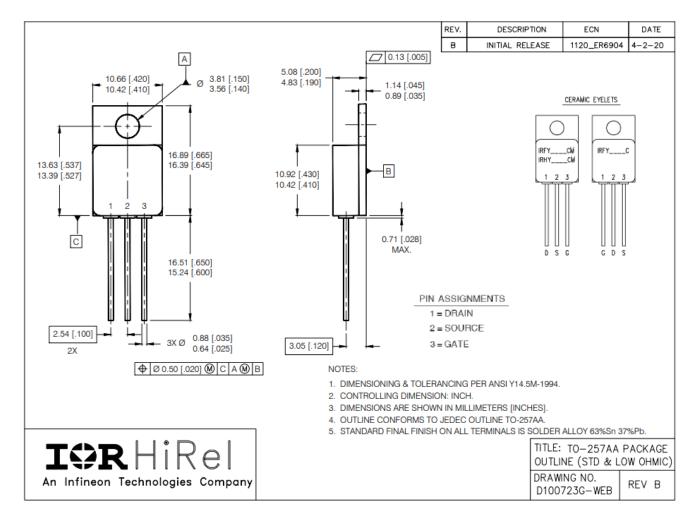




Package Outline

# 5 Package Outline

#### Note: For the most updated package outline, please see the website: TO-257AA



**Revision history** 



# **Revision history**

Document version	Date of release	Description of changes	
	09/22/2003	Final datasheet (PD-91294C)	
Rev D	09/29/2003	Updated per Package outline	
Rev E	09/21/2016	Updated per ECN-1120-04715	
Rev F	12/06/2024	Updated per ECN-1120-10102	

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